



Docket No.: 05165.1520

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PATENT/OFFICIAL

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Richard B. Evans

Serial No. 10/829,269

: Group Art Unit: 3724

Filed: April 22, 2004

: Examiner:

For: CUTTING ANVIL AND METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

No further elaboration is believed necessary. Copies of the documents are submitted herewith in accordance with 37 C.F.R. §1.98(a).

AUTHORIZATION

This Information Disclosure Statement is being filed before receipt of the first Office Action. No fee is required. The Commissioner is hereby authorized to charge any additional fees which may be required for this submission, or credit any overpayment to deposit account no. 50-2036.

Respectfully submitted,

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Date: April 26, 2004

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<p style="text-align: center;">O I P E LIST OF ART CITED BY APPLICANT AUG 26 2004 (PTO-1449)</p>				ATTY. DOCKET NO. 05165.1520	SERIAL NO. 10/829,269		
				APPLICANT Richard B. Evans			
				FILING DATE 4/22/04	GROUP 3724		
U. S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
A	4,133,711	01/09/79	Arthur August, et al.	156	353	06/11/97	
B	5,688,351	11/18/97	John S. Thomas	156	214	04/01/96	
C	4,208,238	06/17/80	Arthur August, et al.	156	510	05/01/78	
D							
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FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
U							
V							
W							
X							
Y							
Z							
AA							
BB							
CC							
DD							
EE							
FF							
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
HH							
II							
JJ							
KK							
LL							
MM							
NN							
EXAMINER				DATE CONSIDERED			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.